

**DRAFT RESPONSE – DO NOT ENTER**Express Mail No. <DRAFT>**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Application of: Newman and de la Fortelle	Confirmation No.: 4507
Serial No.: 10/042,929	Art Unit: 2882
Filed: October 18, 2001	Examiner: Hoon K. Song
For: <i>Apparatus and Method for Identification of Crystals by <u>in-situ</u> X-Ray Diffraction</i>	Attorney Docket No: 10342-0010-999

**DRAFT RESPONSE FOR EXAMINER'S CONSIDERATION**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

The enclosed Amendment is in response to the Office Action dated June 10, 2003 for the above identified patent application.

Petition for Extension of Time under 37 CFR 1.136. It is respectfully requested that the time for response to the Office Action dated June 10, 2003 be extended for a period of one month(s) from September 10, 2003 to and including October 10, 2003. The fee for this extension is estimated to be \$<fee>.

The Commissioner is hereby authorized to charge any required fee(s) to Pennie & Edmonds LLP Deposit Account No. 16-1150. A copy of this sheet is enclosed for such purpose.

**DRAFT**